



EV550720715

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 10/705,685
Confirmation No. 4637
Filing Date November 10, 2003
Inventors John R. Tuttle
Assignee Micron Technology, Inc.
Group Art Unit 2632
Examiner Tai T. Nguyen
Customer No. 021567
Attorney Docket No. MI40-382
Title: Miniature Radio Frequency Transceiver

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References – See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. No admission is made regarding whether all the submitted references are prior art.

Citation of these references is respectfully requested.

Respectfully submitted,

Dated: Sept. 19, 2005

By:

Deepak Malhotra
Reg. No. 33,560

09/23/2005 EFLORES 00000088 10705685

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Form PTO-1449

ATTY. DOCKET NO.
MI40-382SERIAL NO.
10/705,685U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEAPPLICANT
JOHN R. TUTTLE

SEP 19 2005

LIST OF ART CITED BY APPLICANT

(Use several sheets if necessary)

FILING DATE
NOV. 10, 2003GROUP
2632

U.S. PATENT DOCUMENTS

| Examiner Initial | Document Number | Date | Name | Class | Subclass | Filing Date If Appropriate |
|------------------|-----------------|------|------|-------|----------|----------------------------|
| | AA | | | | | |
| | AB | | | | | |
| | AC | | | | | |
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FOREIGN PATENT DOCUMENTS

| | Document Number | Date | Country | Class | Subclass | Translation | |
|----|-----------------|--------|--|-------|----------|-------------|----|
| | | | | | | Yes | No |
| AH | DE 41 20 265 A1 | 6/1991 | Germany (Mitsubishi) See US 5,274,221 (prev. cited) | G06K | 7/01 | Abs | |
| AJ | GB 1 567 784 | 5/1980 | United Kingdom | G06K | 19/00 | | |
| AK | JP 1-191082 | 8/1989 | Japan (Sony Corp.) | G01S | 013/74 | Abs | |
| AL | JP 2-36476 | 3/1990 | Japan (Fijitsu Ltd) | G06F | 015/40 | Abs | |

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

| | |
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| AM | CASSON, K., et al., "High Temperature Packaging: Flip Chip on Flexible Laminate", <u>Surface Mount Technology</u> , pp. 19-20 (1/1992) |
| AN | JOHNSON, R.W., "Polymer Thick Films: Technology and Materials", <u>Circuits Manufacturing</u> (reprint), 4 pages (7/1982) |
| AO | GILLES, K., "Using SM Devices on Flexible Circuitry", <u>ELECTRI-ONICS</u> , pp. 20-23 (3/1986) |
| AP | KANATZIBIS, Mercouri G., "Conductive Polymers", <u>Chemical and Engineering News--American Chemical Society</u> , pp. 36-54 (12/1990) |

EXAMINER DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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|--|----|-----------------|---------|-----------------------------|-------|----------|-------------|----|
| | | | | | | | Yes | No |
| | AH | JP 2-179794 | 7/1990 | Japan (Sony Corp.) | B42D | 015/10 | Abs | |
| | AJ | JP 3-224799 | 10/1991 | Japan (Sony Corp.) | B42D | 015/10 | Abs | |
| | AK | JP 4-359183 | 11/1992 | Japan (Nippondenso Co. Ltd) | G01S | 013/80 | Abs | |
| | AL | | | | | | | |

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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